

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Seiichi BANBA, et al. : Confirmation Number: 5193

Application No.: 10/802,878 : Group Art Unit: 2817

Filed: March 18, 2004 : Examiner: Unknown

For: VARIABLE IMPEDANCE CIRCUIT, VARIABLE GAIN DIFFERENTIAL AMPLIFIER,

MULTIPLIER, HIGH-FREQUENCY CIRCUIT AND DIFFERENTIAL DISTRIBUTED

AMPLIFIER

INFORMATION DISCLOSURE STATEMENT

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Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

The relevance of the Japanese language references; 5-300039, 9-252228, 11-88079, 2003-209448 and 2003-298370, if any, is discussed in the present specification.

10/802,878

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

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SHEET 1 OF 1

INFORMATION DIS ATTY, DOCKET NO. SERIAL NO. 50024-026 10/802,878 CITATION IN AN APPLICATION APPLICANT Seiichi BANBA, et al. FILING DATE **GROUP** (PTO-1449) March 18, 2004 2817 U.S. PATENT DOCUMENTS **EXAMINER'S** CITE **Document Number Publication Date** Name of Patentee or Applicant of Cited Pages, Columns, Lines, Where MM-DD-YYYY INITIALS NO. Document Relevant Passages or Relevant Number-Kind Code2 (# known) Figures Appear บรั 6,597,243 B1 7/22/2003 Fratti Corresponds to JP 2003-209448 US 2003/0184383 A1 10/2/2003 Corresponds to JP 2003-298370 Ogawa υs US ŪS US US บร US US US US US UŞ FOREIGN PATENT DOCUMENTS **EXAMINER'S** Foreign Patent Document Publication Date Name of Patentee or Pages, Columns, Lines Translation INITIALS CITE Country Codes-Number 4-Kind MM-DD-YYYY Applicant of Cited Document Where Relevant NO. Codes (if known) Figures Appear Yes No JP 05-300039 11/12/1993 **TOSHIBA CORP** w/English Abstract JP 09-252228 9/22/1997 NIPPON TELEGR & w/English Abstract TELEPH CORP JP 11-088079 3/30/1999 w/English Abstract HITACHI LTD JP 2003-209448 A 7/25/2003 Corresponds to U.S. 6,597,243 JP 2003-298370 A 10/17/2003 Corresponds to U.S. 2003-0184383 JP 10-261926 9/29/1998 HITACHI LTD w/English Abstract JP 2003-168937 A 6/13/2003 SANYO ELECTRIC CO LTD w/English Abstract JP 2003-168938 A 6/13/2003 SANYO ELECTRIC CO LTD w/English Abstract OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) **EXAMINER'S** Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, INITIALS journal, senal, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where CITE published. NO. **EXAMINER** DATE CONSIDERED

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